

### General Description

The AO4616 uses advanced trench technology to provide excellent  $R_{DS(ON)}$  and low gate charge. This complementary N and P channel MOSFET configuration is ideal for low Input Voltage inverter applications.

### Product Summary

#### N-Channel

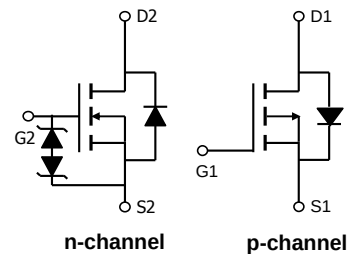
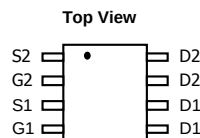
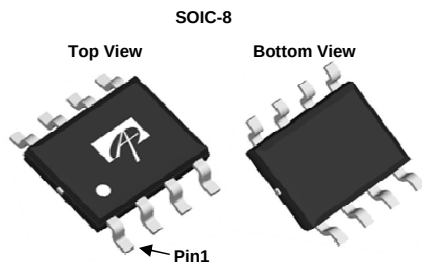
$V_{DS} = 30V$   
 $I_D = 8A$  ( $V_{GS}=10V$ )  
 $R_{DS(ON)}$   
< 20m $\Omega$  ( $V_{GS}=10V$ )  
< 28m $\Omega$  ( $V_{GS}=4.5V$ )

100% UIS Tested  
100%  $R_g$  Tested  
**ESD Protected**

#### P-Channel

-30V  
-7A ( $V_{GS}=-10V$ )  
 $R_{DS(ON)}$   
< 22m $\Omega$  ( $V_{GS}=-10V$ )  
< 40m $\Omega$  ( $V_{GS}=-4.5V$ )

100% UIS Tested  
100%  $R_g$  Tested



### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

| Parameter                               | Symbol           | Max n-channel | Max p-channel | Units      |
|-----------------------------------------|------------------|---------------|---------------|------------|
| Drain-Source Voltage                    | $V_{DS}$         | 30            | -30           | V          |
| Gate-Source Voltage                     | $V_{GS}$         | $\pm 20$      | $\pm 20$      | V          |
| Continuous Drain Current                | $I_D$            | 8             | -7            | A          |
|                                         |                  | 6.5           | -6            |            |
| Pulsed Drain Current <sup>C</sup>       | $I_{DM}$         | 40            | -40           |            |
| Avalanche Current <sup>C</sup>          | $I_{AS}, I_{AR}$ | 19            | 27            | A          |
| Avalanche energy $L=0.1mH$ <sup>C</sup> | $E_{AS}, E_{AR}$ | 18            | 36            | mJ         |
| Power Dissipation <sup>B</sup>          | $P_D$            | 2             | 2             | W          |
|                                         |                  | 1.3           | 1.3           |            |
| Junction and Storage Temperature Range  | $T_J, T_{STG}$   | -55 to 150    |               | $^\circ C$ |

### Thermal Characteristics

| Parameter                                  | Symbol          | Typ | Max  | Units        |
|--------------------------------------------|-----------------|-----|------|--------------|
| Maximum Junction-to-Ambient <sup>A</sup>   | $R_{\theta JA}$ | 48  | 62.5 | $^\circ C/W$ |
| Maximum Junction-to-Ambient <sup>A D</sup> |                 | 74  | 90   | $^\circ C/W$ |
| Maximum Junction-to-Lead                   | $R_{\theta JL}$ | 32  | 40   | $^\circ C/W$ |

**N-Channel Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                                | Min | Typ        | Max      | Units |
|-----------------------------|---------------------------------------|-------------------------------------------------------------------------------------------|-----|------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                           |     |            |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V                                                | 30  |            |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |     |            | 1<br>5   | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±16V                                                |     |            | 10       | μA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                  | 1.2 | 1.8        | 2.4      | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =10V, V <sub>DS</sub> =5V                                                 | 40  |            |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =10V, I <sub>D</sub> =8A<br>T <sub>J</sub> =125°C                         |     | 16.5<br>23 | 20<br>28 | mΩ    |
|                             |                                       | V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A                                                 |     | 19.5       | 28       | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =5V, I <sub>D</sub> =8A                                                   |     | 30         |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =1A, V <sub>GS</sub> =0V                                                   |     | 0.75       | 1        | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                           |     |            | 2.5      | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                           |     |            |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz                                         | 600 | 740        | 888      | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                           | 77  | 110        | 145      | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                           | 50  | 82         | 115      | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                          | 0.5 | 1.1        | 1.7      | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                           |     |            |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =8A                            | 12  | 15         | 18       | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                     |                                                                                           | 6   | 7.5        | 9        | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                           |     | 2.5        |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                           |     | 3          |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =1.8Ω,<br>R <sub>GEN</sub> =3Ω |     | 5          |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                           |     | 3.5        |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                           |     | 19         |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                           |     | 3.5        |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =8A, dI/dt=500A/μs                                                         | 6   | 8          | 10       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =8A, dI/dt=500A/μs                                                         | 14  | 18         | 22       | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

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**N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

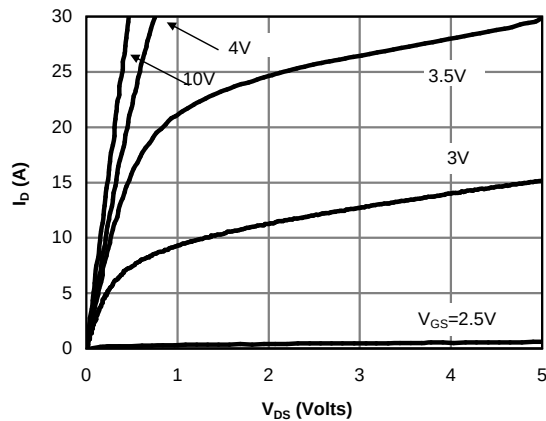


Figure 1: On-Region Characteristics (Note E)

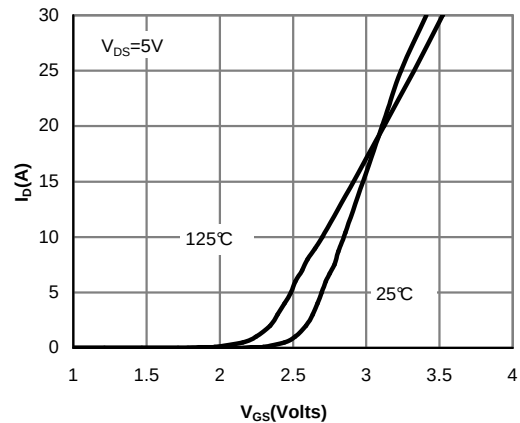


Figure 2: Transfer Characteristics (Note E)

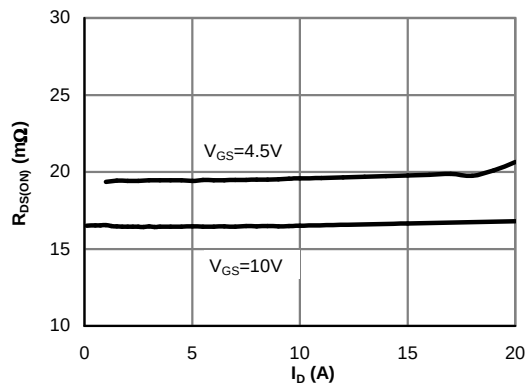


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

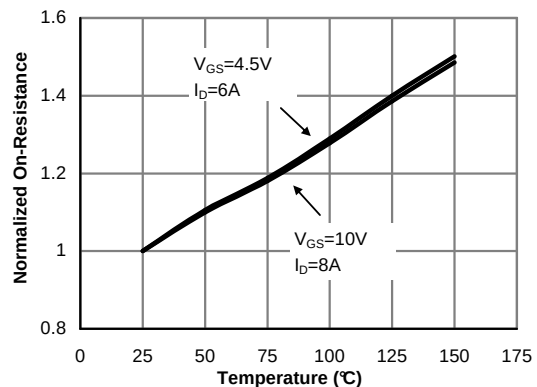


Figure 4: On-Resistance vs. Junction Temperature (Note E)

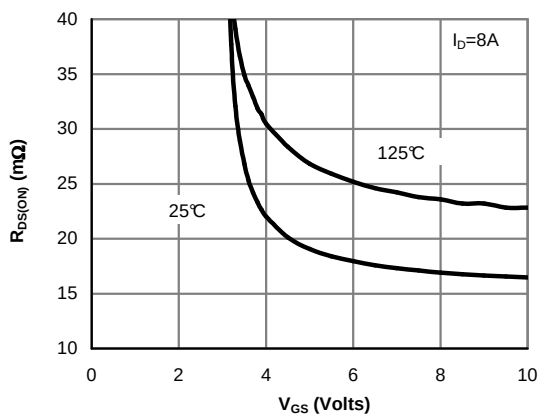


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

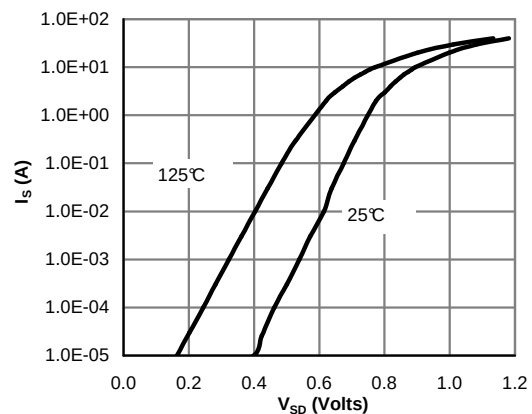


Figure 6: Body-Diode Characteristics (Note E)

**N-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

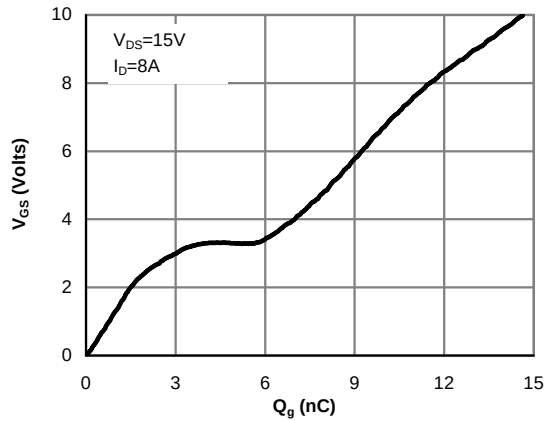


Figure 7: Gate-Charge Characteristics

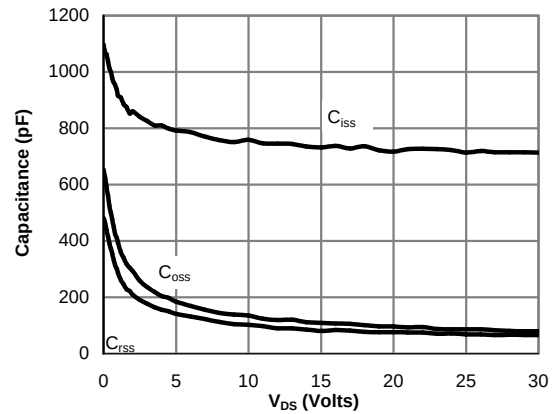


Figure 8: Capacitance Characteristics

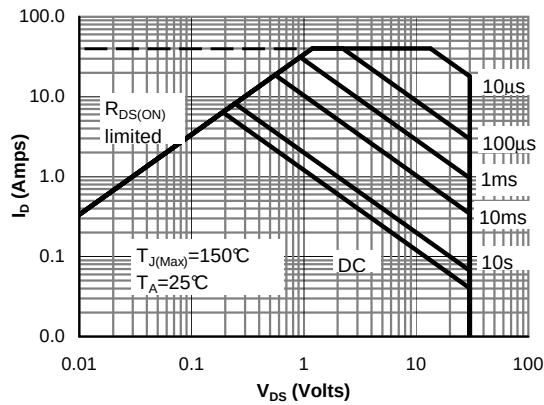


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

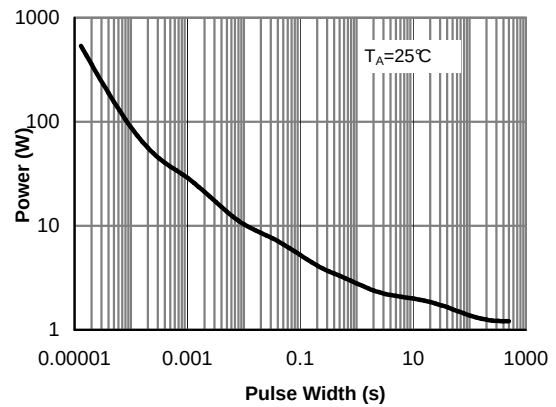


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

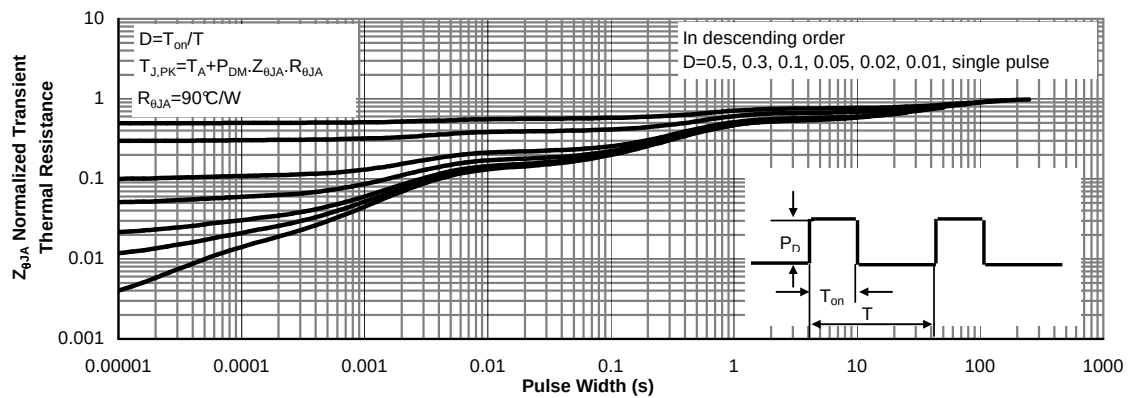
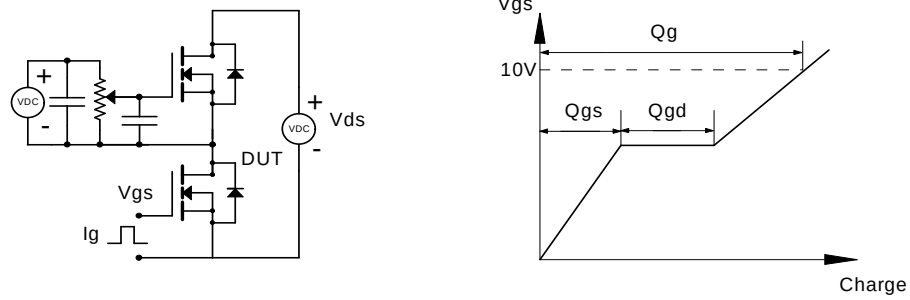
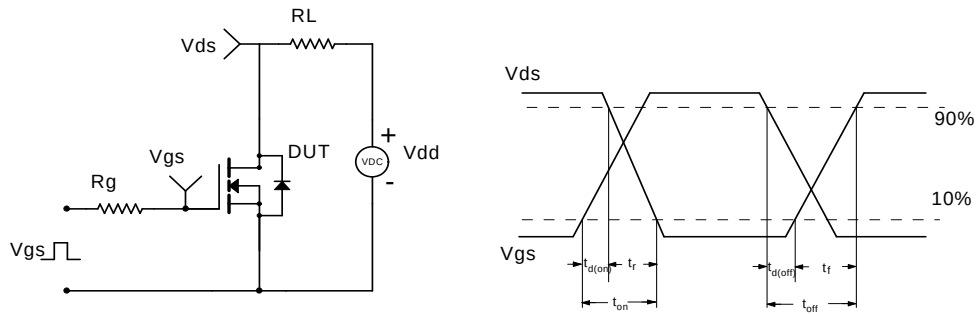


Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)

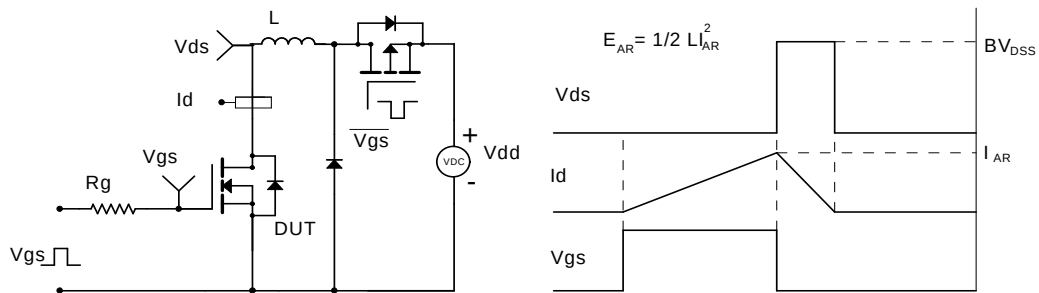
### Gate Charge Test Circuit & Waveform



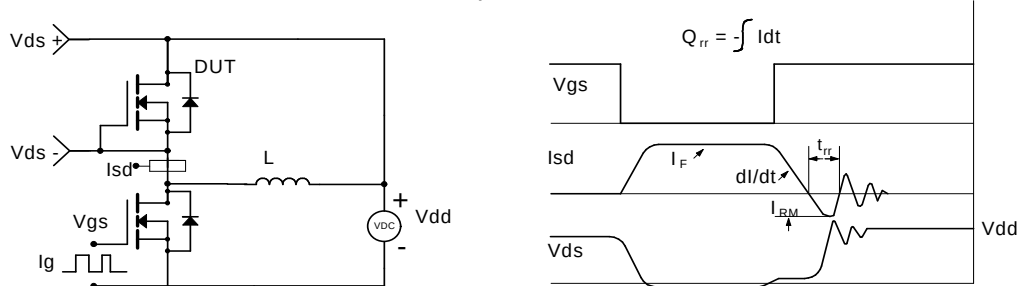
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms



**P-Channel Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions                                                                                 | Min  | Typ          | Max      | Units |
|-----------------------------|---------------------------------------|--------------------------------------------------------------------------------------------|------|--------------|----------|-------|
| <b>STATIC PARAMETERS</b>    |                                       |                                                                                            |      |              |          |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage        | I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V                                                | -30  |              |          | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current       | V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                         |      |              | -1<br>-5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current             | V <sub>DS</sub> =0V, V <sub>GS</sub> =±20V                                                 |      |              | 100      | nA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                | V <sub>DS</sub> =V <sub>GS</sub> I <sub>D</sub> =-250μA                                    | -1.4 | -2.0         | -2.5     | V     |
| I <sub>D(ON)</sub>          | On state drain current                | V <sub>GS</sub> =-10V, V <sub>DS</sub> =-5V                                                | -40  |              |          | A     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance     | V <sub>GS</sub> =-10V, I <sub>D</sub> =-7A<br>T <sub>J</sub> =125°C                        |      | 17.5<br>24.5 | 22<br>33 | mΩ    |
|                             |                                       | V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3.5A                                              |      | 27.5         | 40       | mΩ    |
|                             |                                       |                                                                                            |      |              |          |       |
| g <sub>FS</sub>             | Forward Transconductance              | V <sub>DS</sub> =-5V, I <sub>D</sub> =-7A                                                  |      | 24           |          | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                 | I <sub>S</sub> =-1A, V <sub>GS</sub> =0V                                                   |      | -0.75        | -1       | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current |                                                                                            |      |              | -2.5     | A     |
| <b>DYNAMIC PARAMETERS</b>   |                                       |                                                                                            |      |              |          |       |
| C <sub>iss</sub>            | Input Capacitance                     | V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz                                         | 830  | 1040         | 1250     | pF    |
| C <sub>oss</sub>            | Output Capacitance                    |                                                                                            | 125  | 180          | 235      | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance          |                                                                                            | 75   | 125          | 175      | pF    |
| R <sub>g</sub>              | Gate resistance                       | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz                                           | 2    | 4            | 6        | Ω     |
| <b>SWITCHING PARAMETERS</b> |                                       |                                                                                            |      |              |          |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-7A                           | 15   | 19           | 23       | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                     |                                                                                            | 7.5  | 9.6          | 12       | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                    |                                                                                            |      | 3.6          |          | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                     |                                                                                            |      | 4.6          |          | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                     | V <sub>GS</sub> =10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =2.2Ω,<br>R <sub>GEN</sub> =3Ω |      | 10           |          | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                     |                                                                                            |      | 5.5          |          | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                    |                                                                                            |      | 26           |          | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                    |                                                                                            |      | 9            |          | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time      | I <sub>F</sub> =-7A, dI/dt=500A/μs                                                         |      | 11.5         | 15       | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge    | I <sub>F</sub> =-7A, dI/dt=500A/μs                                                         |      | 25           | 32.5     | nC    |

A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150°C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25°C.

D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to lead R<sub>θJL</sub> and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-ambient thermal impedance which is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.

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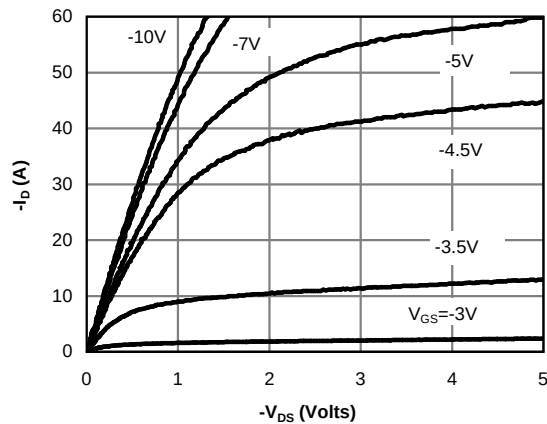


Figure 1: On-Region Characteristics (Note E)

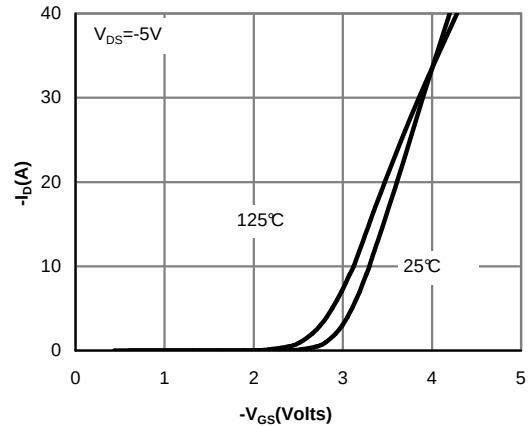


Figure 2: Transfer Characteristics (Note E)

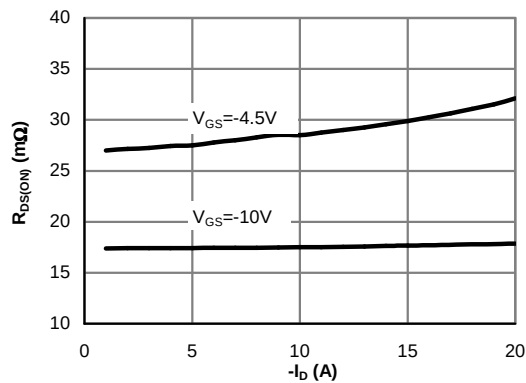


Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

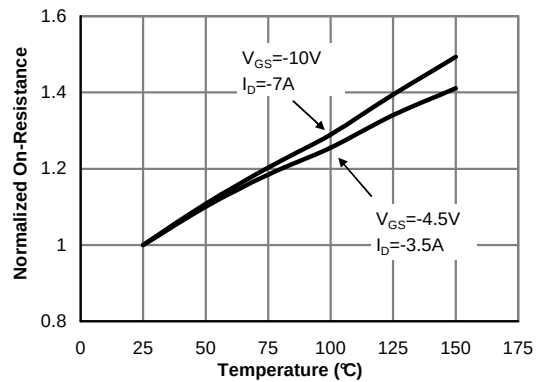


Figure 4: On-Resistance vs. Junction Temperature (Note E)

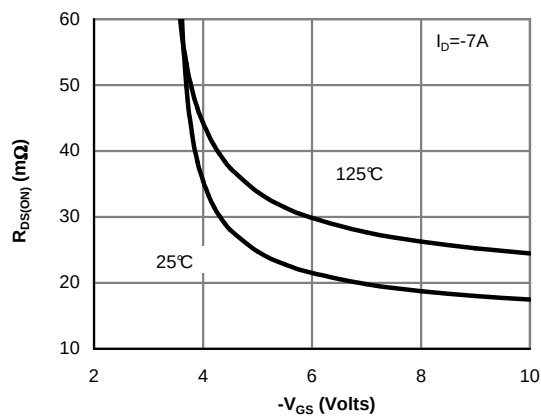


Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)

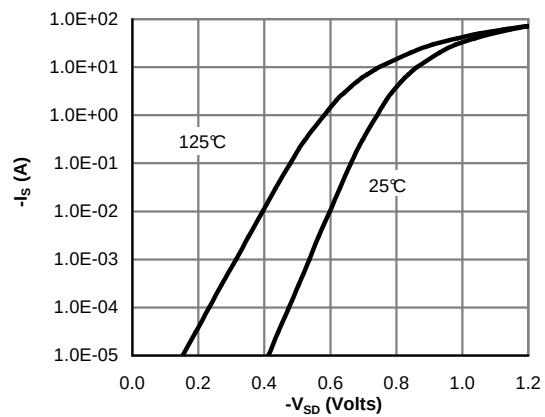


Figure 6: Body-Diode Characteristics (Note E)

**P-Channel: TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

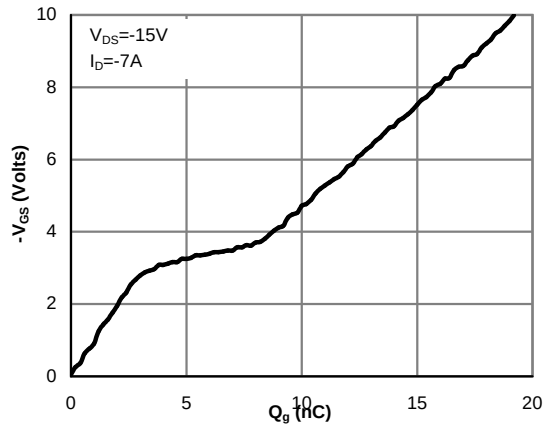


Figure 7: Gate-Charge Characteristics

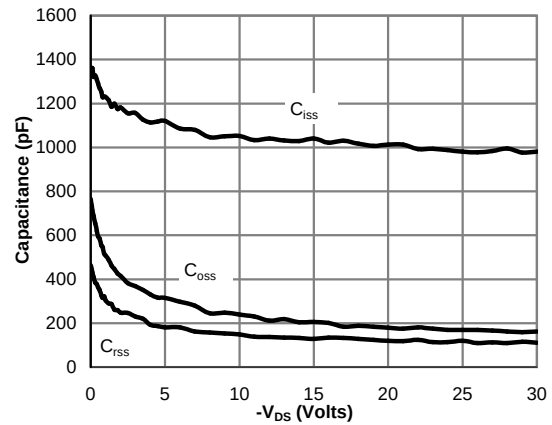


Figure 8: Capacitance Characteristics

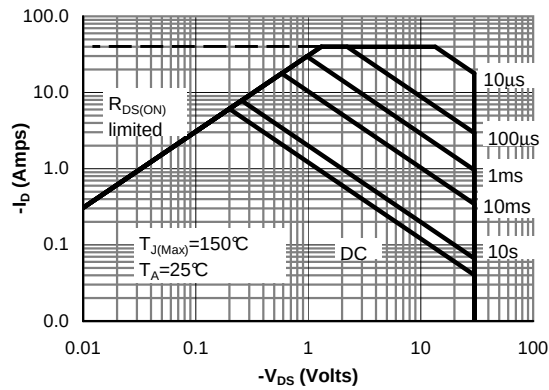


Figure 9: Maximum Forward Biased Safe Operating Area (Note F)

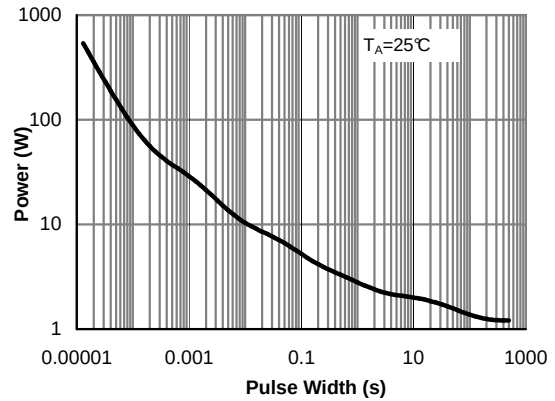


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note F)

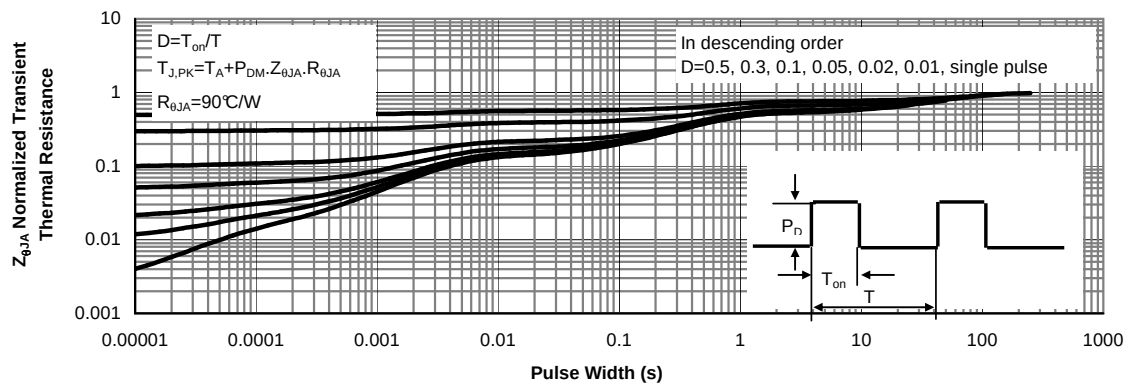
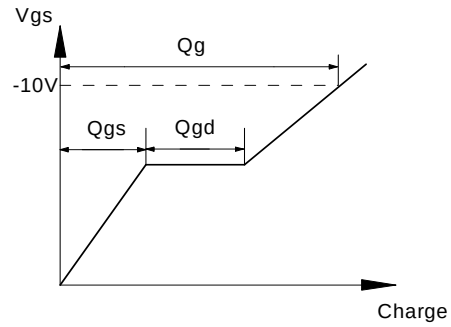
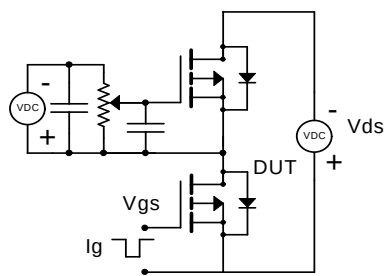


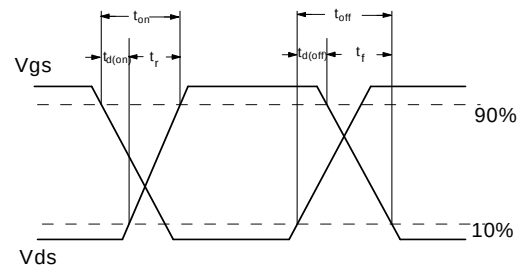
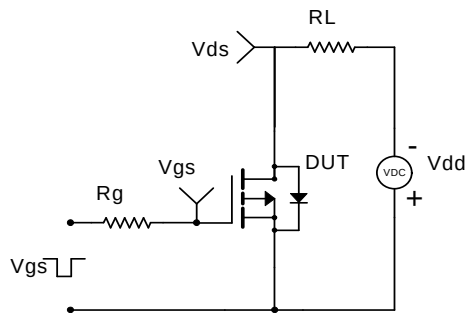
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



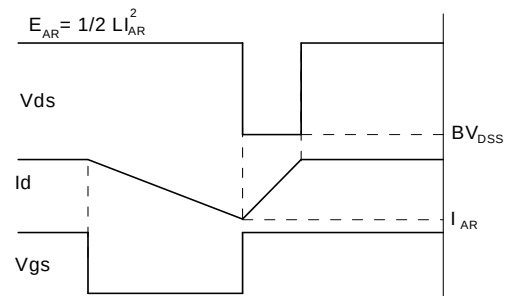
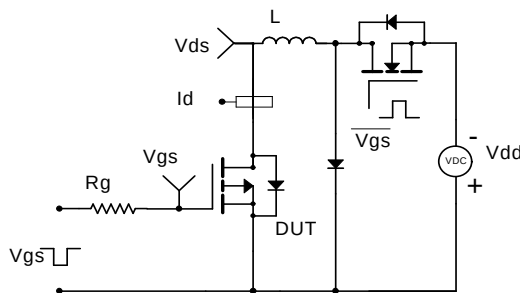
### Gate Charge Test Circuit & Waveform



### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



### Diode Recovery Test Circuit & Waveforms

